

Application/Control	No
10/565,122	

Examiner TAN Q. NGUYEN Applicant(s)/Patent under Reexamination

NICAISE, JEAN-LOUIS

Art Unit 3661

				ISSUE	CL	.AS	SIF	ICAT	ION						
		ORIGINAL		INTERNATIONAL CLASSIFICATION											
	LASS			CI	AIMED	NON-CLAIMED									
	5	В	60	R	21	/01	G	06	F	19	/00				
	CROSS REFERENCES							21	/32					,	
CLASS	SUBCLA	SS (ONE SU	6	60	R	21	132					1			
701	301								1						
280	735								1					1	
									1				1		
									1					1	
									1					1	
rassisiani examineri irraier 🔳						NGL			Total Claims Allowed: 19						
(Legal Instruments Examiner) (Date) (Primary E							3, 20	(Date)	O.G. Print Claim(s)					O.G. Print Fig.	

	Claims renumbered in the same order as presented by applicant									□СРА			☐ T.D.			☐ R.1.47			
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1]		31			61]		91			121			151			181
2	2			32			62			92			122			152			182
3	3			33			63]		93			123			153			183
4	4]		34			64			94			124			154			184
5	5			35			65			95			125			155			185
	6			36			66			96			126			156			186
	7]		37			67]		97			127			157			187
6	8]		38			68			98			128			158			188
7	9]		39			69			99			129			159			189
8	10			40			70			100			130			160			190
9	11]		41			71]		101			131			161			191
10	12]		42			72			102			132			162			192
11	13]		43			73	Į		103			133			163			193
12	14]		44			74]		104			134			164			194
16	15]		45			75	ļ		105			135			165			195
13	16]		46			76			106			136			166			196
14	17]		47			77	[107			137			167			197
15	18]		48			78			108			138			168			198
17	19]		49			79]		109			139			169			199
18	20]		50			80			110			140			170			200
19	21			51			81	Į		111			141			171			201
	22			52			82	ļ		112			142			172			202
	23]		53			83			113			143			173			203
	24]		54			84	Į		114			144			174			204
	25]		55			85	Į		115			145			175			205
	26]		56			86	Į		116			146			176			206
	27]		57			87	[117			147			177			207
	28]		58			88]		118			148			178			208
	29]		59			89	[119			149			179			209
	30			60			90			120			150			180			210